

Notice of References Cited	Application/Control No. 10/038,870	Applicant(s)/Patent Under Reexamination JOHANNSEN, PEER	
	Examiner Paul Dinh	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Reducing bitvector satisfiability problems to scale down design sizes for RTL property checking, Peer Johannsen, workshop 2001. Proceedings. Sixth IEEE International, 7-9 Nov. 2001, pages: 123-128
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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